

**TC74AC273P, TC74AC273F, TC74AC273FW, TC74AC273FT****OCTAL D - TYPE FLIP FLOP WITH CLEAR**

The TC74AC273 is an advanced high speed CMOS OCTAL D - TYPE FLIP FLOP fabricated with silicon gate and double-layer metal wiring C2MOS technology.

It achieves the high speed operation similar to equivalent Bipolar Schottky TTL while maintaining the CMOS low power dissipation.

Information signals applied to D inputs are transferred to the Q output on the positive going edge of the clock pulse.

When the CLR input is held "L", the Q outputs are at a low logic level independent of the other inputs.

All inputs are equipped with protection circuits against static discharge or transient excess voltage.

**FEATURES :**

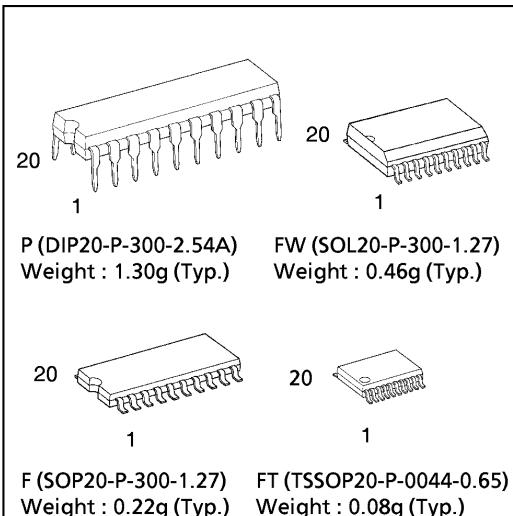
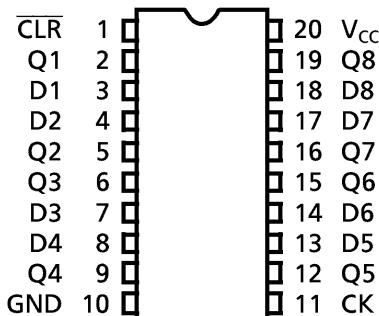
- High Speed..... $f_{MAX} = 170\text{MHz}(\text{typ.})$   
at  $V_{CC} = 5\text{V}$
- Low Power Dissipation..... $I_{CC} = 8\mu\text{A}(\text{Max.})$  at  $T_a = 25^\circ\text{C}$
- High Noise Immunity..... $V_{NIH} = V_{NIL} = 28\% V_{CC}$  (Min.)
- Symmetrical Output Impedance... $|I_{OH}| = |I_{OL}| = 24\text{mA}(\text{Min.})$   
Capability of driving  $50\Omega$   
transmission lines.
- Balanced Propagation Delays..... $t_{PLH} \approx t_{PHL}$
- Wide Operating Voltage Range.... $V_{CC} (\text{opr}) = 2\text{V} \sim 5.5\text{V}$
- Pin and Function Compatible with 74F273

**TRUTH TABLE**

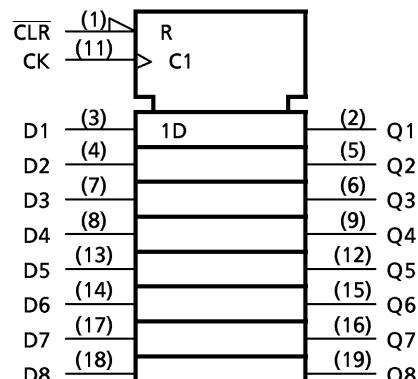
INPUTS			OUTPUTS	FUNCTION
CLR	D	CK	Q	
L	X	X	L	CLEAR
H	L	—	L	—
H	H	—	H	—
H	X	—	$Q_n$	NO CHANGE

X : Don't Care

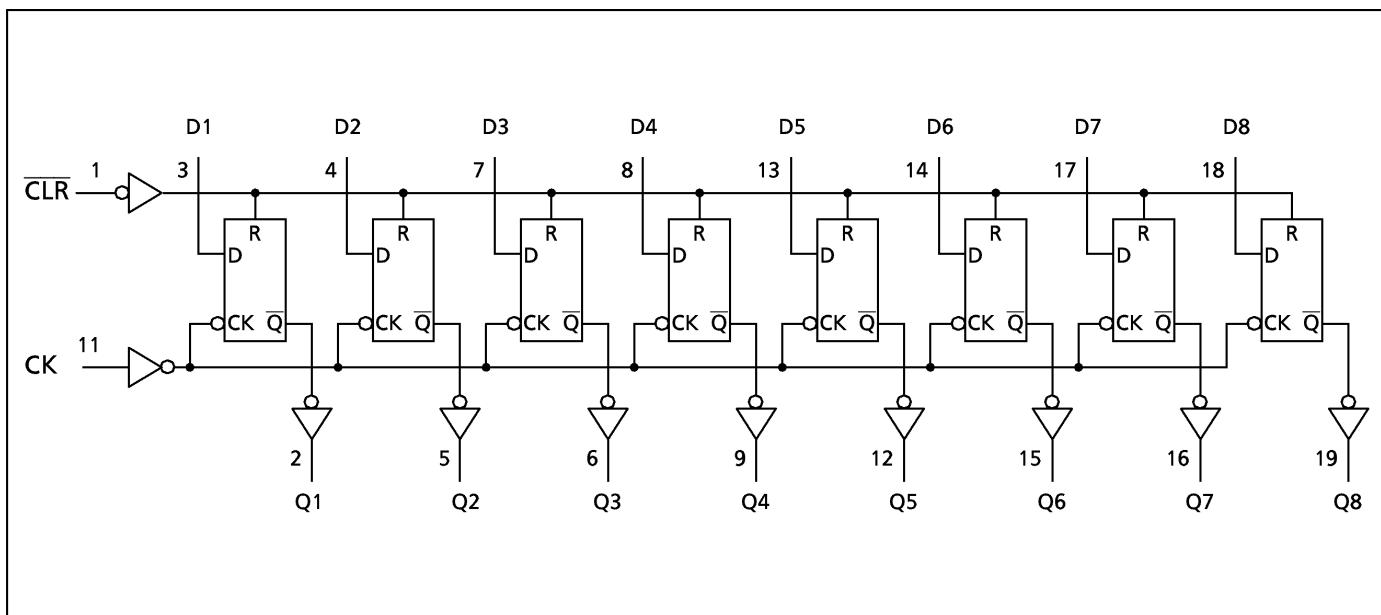
(Note) The JEDEC SOP (FW) is not available in Japan.

**PIN ASSIGNMENT**

(TOP VIEW)

**IEC LOGIC SYMBOL**

## SYSTEM DIAGRAM



## ABSOLUTE MAXIMUM RATINGS

PARAMETER	SYMBOL	VALUE	UNIT
Supply Voltage Range	$V_{CC}$	-0.5~7.0	V
DC Input Voltage	$V_{IN}$	-0.5~ $V_{CC} + 0.5$	V
DC Output Voltage	$V_{OUT}$	-0.5~ $V_{CC} + 0.5$	V
Input Diode Current	$I_{IK}$	$\pm 20$	mA
Output Diode Current	$I_{OK}$	$\pm 50$	mA
DC Output Current	$I_{OUT}$	$\pm 50$	mA
DC $V_{CC}$ /Ground Current	$I_{CC}$	$\pm 200$	mA
Power Dissipation	$P_D$	500 (DIP)*/ 180 (SOP/TSSOP)	mW
Storage Temperature	$T_{STG}$	-65~150	°C

\*500mW in the range of  $T_a = -40^{\circ}\text{C} \sim 65^{\circ}\text{C}$ . From  $T_a = 65^{\circ}\text{C}$  to  $85^{\circ}\text{C}$  a derating factor of  $-10\text{mW}/^{\circ}\text{C}$  should be applied up to 300mW.

## RECOMMENDED OPERATING CONDITIONS

PARAMETER	SYMBOL	VALUE	UNIT
Supply Voltage	$V_{CC}$	2.0~5.5	V
Input Voltage	$V_{IN}$	0~ $V_{CC}$	V
Output Voltage	$V_{OUT}$	0~ $V_{CC}$	V
Operating Temperature	$T_{opr}$	-40~85	°C
Input Rise and Fall Time	$dt/dV$	0~ 100 ( $V_{CC} = 3.3 \pm 0.3\text{V}$ ) 0~ 20 ( $V_{CC} = 5 \pm 0.5\text{V}$ )	ns / V

## DC ELECTRICAL CHARACTERISTICS

PARAMETER	SYMBOL	TEST CONDITION	$V_{CC}$ (V)	Ta = 25°C			Ta = -40~85°C		UNIT	
				MIN.	TYP.	MAX.	MIN.	MAX.		
High - Level Input Voltage	$V_{IH}$		2.0 3.0 5.5	1.50 2.10 3.85	— — —	— — —	1.50 2.10 3.85	— — —	V	
Low - Level Input Voltage	$V_{IL}$		2.0 3.0 5.5	— — —	— — —	0.50 0.90 1.65	— — —	0.50 0.90 1.65	V	
High - Level Output Voltage	$V_{OH}$	$V_{IN} = V_{IH}$ or $V_{IL}$	$I_{OH} = -50\mu A$	2.0 3.0 4.5	1.9 2.9 4.4	2.0 3.0 4.5	— — —	1.9 2.9 4.4	— — —	
			$I_{OH} = -4mA$ $I_{OH} = -24mA$ $I_{OH} = -75mA^*$	3.0 4.5 5.5	2.58 3.94 —	— — —	— — —	2.48 3.80 3.85	— — —	
		$V_{IN} = V_{IH}$ or $V_{IL}$	$I_{OL} = 50\mu A$	2.0 3.0 4.5	— — —	0.0 0.0 0.0	0.1 0.1 0.1	— — —	0.1 0.1 0.1	
			$I_{OL} = 12mA$ $I_{OL} = 24mA$ $I_{OL} = 75mA^*$	3.0 4.5 5.5	— — —	— — —	0.36 0.36 —	— — —	0.44 0.44 1.65	
Input Leakage Current	$I_{IN}$	$V_{IN} = V_{CC}$ or GND		5.5	—	—	$\pm 0.1$	—	$\pm 1.0$	$\mu A$
Quiescent Supply Current	$I_{CC}$	$V_{IN} = V_{CC}$ or GND		5.5	—	—	8.0	—	80.0	

\* : This spec indicates the capability of driving  $50\Omega$  transmission lines.

One output should be tested at a time for a 10ms maximum duration.

TIMING REQUIREMENTS ( Input  $t_r = t_f = 3ns$  )

PARAMETER	SYMBOL	TEST CONDITION	$V_{CC}$ (V)	Ta = 25°C		Ta = -40~85°C		UNIT
				LIMIT	LIMIT	LIMIT	LIMIT	
Minimum Pulse Width ( CK )	$t_W(L)$ $t_W(H)$		$3.3 \pm 0.3$ $5.0 \pm 0.5$	8.0 5.0	— —	8.0 5.0	— —	ns
Minimum Pulse Width ( CLR )	$t_W(L)$		$3.3 \pm 0.3$ $5.0 \pm 0.5$	7.5 5.0	— —	7.5 5.0	— —	
Minimum Set - up Time	$t_s$		$3.3 \pm 0.3$ $5.0 \pm 0.5$	8.5 4.5	— —	8.5 4.5	— —	
Minimum Hold Time	$t_h$		$3.3 \pm 0.3$ $5.0 \pm 0.5$	0.0 0.0	— —	0.0 0.0	— —	
Minimum Removal Time ( CLR )	$t_{rem}$		$3.3 \pm 0.3$ $5.0 \pm 0.5$	7.0 3.5	— —	7.0 3.5	— —	

AC ELECTRICAL CHARACTERISTICS ( $C_L = 50\text{pF}$ ,  $R_L = 500\Omega$ , Input  $t_r = t_f = 3\text{ns}$ )

PARAMETER	SYMBOL		TEST CONDITION		$T_a = 25^\circ\text{C}$			$T_a = -40 \sim 85^\circ\text{C}$		UNIT
			$V_{CC}$ (V)	MIN.	TYP.	MAX.	MIN.	MAX.		
Propagation Delay Time (CK-Q)	$t_{PLH}$ $t_{PHL}$		$3.3 \pm 0.3$	—	9.0	15.8	1.0	18.0	ns	
			$5.0 \pm 0.5$	—	6.5	9.6	1.0	11.0		
Propagation Delay Time (CLR-Q)	$t_{PHL}$		$3.3 \pm 0.3$	—	8.0	14.0	1.0	16.0	ns	
			$5.0 \pm 0.5$	—	5.9	9.2	1.0	10.5		
Maximum Clock Frequency	$f_{MAX}$		$3.3 \pm 0.3$	55	110	—	55	—	MHz	
Input Capacitance	$C_{IN}$		$5.0 \pm 0.5$	90	150	—	90	—		
Power Dissipation Capacitance	$C_{PD}(1)$			—	40	—	—	—	pF	

Note (1)  $C_{PD}$  is defined as the value of the internal equivalent capacitance which is calculated from the operating current consumption without load.

Average operating current can be obtained by the equation :

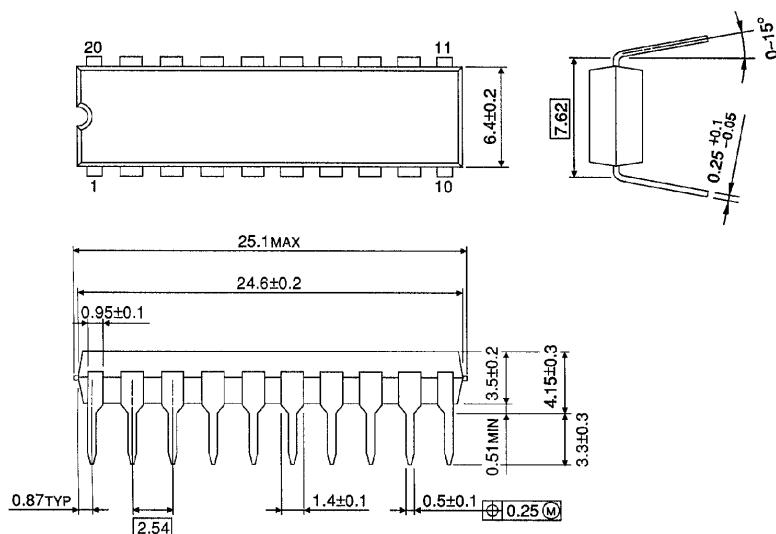
$$I_{CC}(\text{opr.}) = C_{PD} \cdot V_{CC} \cdot f_{IN} + I_{CC}/8 \text{ (per F/F)}$$

And the total  $C_{PD}$  when n pcs. of Flip Flop operate can be gained by the following equation :

$$C_{PD}(\text{total}) = 29 + 11 \cdot n$$

## DIP 20PIN PACKAGE DIMENSIONS (DIP20-P-300-2.54A)

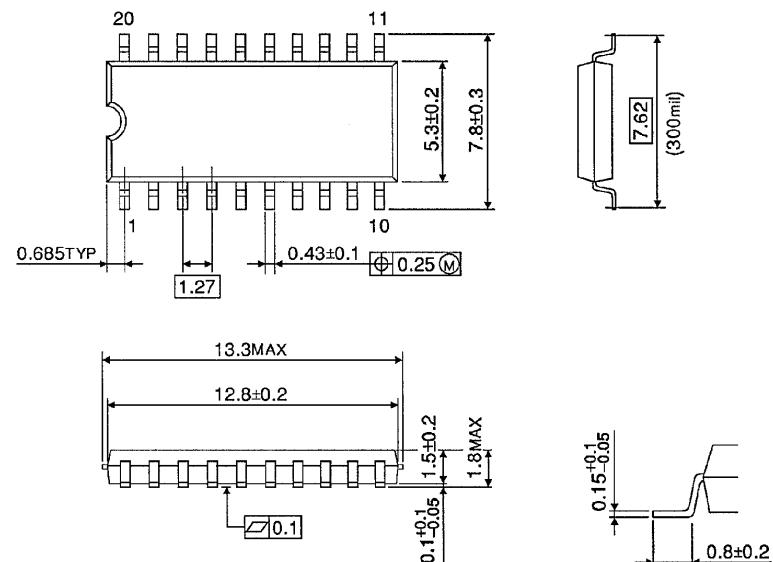
Unit in mm



Weight : 1.30g (Typ.)

## SOP 20PIN (200mil BODY) PACKAGE DIMENSIONS (SOP20-P-300-1.27)

Unit in mm

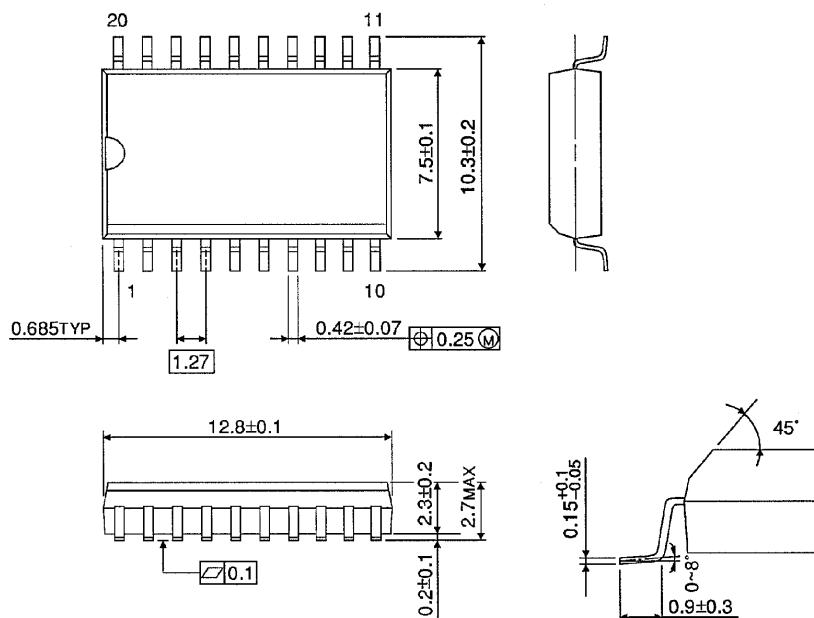


Weight : 0.22g (Typ.)

## SOP 20PIN (300mil BODY) PACKAGE DIMENSIONS (SOL20-P-300-1.27)

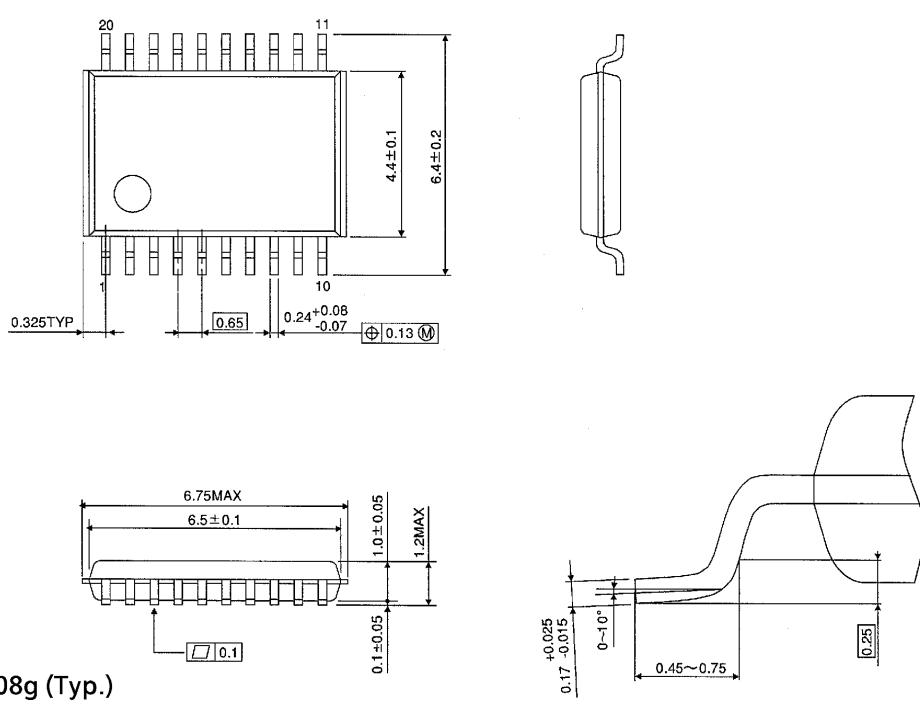
Unit in mm

(Note) This package is not available in Japan.



## TSSOP 20PIN PACKAGE DIMENSIONS (TSSOP20-P-0044-0.65)

Unit in mm



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000707EBA

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